Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/787,493	LAMKE ET AL.
Examiner	Art Unit
Anabel M. Ton	2875

SEARCHED			
Class	Subclass	Date	Examiner
362	226,800,2 49		
	267		
	310		
313	512		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
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